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SYNTHESIS OF TAYLOR AND BAYLISS PATTERNS FOR LINEAR ANTENNA ARR--ETC(U)
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NRL Report 8511

Synthesis of Taylor and Bayliss Patterns for Linear Antenna Arrays

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August 31, 1981



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REPORT DOCUMENTATION PAGE		READ INSTRUCTIONS BEFORE COMPLETING FORM
1. REPORT NUMBER NRL Report 8511	2. GOVT ACCESSION NO. AD-A103 534	3. RECIPIENT'S CATALOG NUMBER
4. TITLE (and Subtitle) SYNTHESIS OF TAYLOR AND BAYLISS PATTERNS FOR LINEAR ANTENNA ARRAYS	5. TYPE OF REPORT & PERIOD COVERED Interim report on a continuing NRL problem.	
7. AUTHOR(s) J. P. Shelton	6. PERFORMING ORG. REPORT NUMBER	
9. PERFORMING ORGANIZATION NAME AND ADDRESS Naval Research Laboratory Washington, DC 20375	8. CONTRACT OR GRANT NUMBER(s) 101-11111	
11. CONTROLLING OFFICE NAME AND ADDRESS	10. PROGRAM ELEMENT, PROJECT, TASK AREA & WORK UNIT NUMBERS 62712N; SF 12141491 53-0604-0 17	
14. MONITORING AGENCY NAME & ADDRESS (if different from Controlling Office)	12. REPORT DATE August 31, 1981	
18. DISTRIBUTION STATEMENT (of this Report)	13. NUMBER OF PAGES 19	
17. DISTRIBUTION STATEMENT (of the abstract entered in Block 20, if different from Report)	15. SECURITY CLASS. (of this report) UNCLASSIFIED	
16. SUPPLEMENTARY NOTES	15a. DECLASSIFICATION/DOWNGRADING SCHEDULE DTIC C-1 H	
19. KEY WORDS (Continue on reverse side if necessary and identify by block number) Antennas Linear arrays Pattern synthesis Sidelobe control	20. ABSTRACT (Continue on reverse side if necessary and identify by block number) The history of synthesis techniques for designing linear antenna arrays with low sidelobe patterns is reviewed briefly, and the limitations that are encountered with very low sidelobes and/or small arrays are pointed out. Taylor's continuous aperture synthesis procedure is outlined, and a technique for transforming it for application to a discrete array is described. Discrete-array design equations for Taylor and Bayliss synthesis procedures are given. A set of programs for use on a programmable calculator are presented.	

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SYNTHESIS OF TAYLOR AND BAYLISS PATTERNS FOR LINEAR ANTENNA ARRAYS

INTRODUCTION

The requirement for low sidelobes from array-type antennas is a long-standing one. The contributions to this theory extend from Dolph's utilization of Chebyshev polynomials, through Taylor's papers on linear and circular apertures, Bayliss's extension to difference-type patterns, and finally to recently developed techniques which provide arbitrary pattern control for linear arrays [1-8].

The purpose of this report is to examine some of the more recent applications of these synthesis techniques in light of their limitations and also the computational capabilities which are now available. For example, at the time Taylor published his synthesis procedure, engineers had only slide rules, mathematical tables, and mechanical desk calculators to generate the distribution functions. The computational capability available to today's engineer is vastly different, and we will show how Taylor's and Bayliss's procedures can be modified to give better results.

A more careful look at the synthesis procedures previously mentioned is presented in Table 1.

Dolph's synthesis is precise and gives minimum beamwidth for given sidelobe levels, but these constant amplitude sidelobes are not desirable for larger arrays because it is possible to radiate most of the energy into the sidelobes. Taylor solved this problem by allowing the far-out sidelobes to fall off as dictated by an amplitude discontinuity at the ends of the aperture. Taylor, and later Bayliss, synthesized continuous distributions and sampled these to obtain array excitations.

Table 1 — Synthesis Procedures for Linear Array Apertures

Procedure/ Date	Continuous or Discrete	Limitations
Dolph/47	Discrete	Poor results for large arrays
Taylor/52	Continuous	Inexact for low sidelobes, small arrays
Bayliss/68	Continuous	Inexact for low sidelobes, small arrays
Hyneman/68	Continuous	Inexact for low sidelobes, small arrays—iterative
Stutzman/72	Continuous	Inexact for low sidelobes, small arrays—iterative
Elliott/76	Continuous	Inexact for low sidelobes, small arrays—iterative
Elliott/77	Discrete	Applies all continuous procedures to discrete arrays

Manuscript submitted June 15, 1981.

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Some recent applications have called for lower sidelobes and smaller arrays, thereby pressing the limitations of the Taylor and Bayliss synthesis procedures. The problem of discretizing continuous aperture distributions has been treated [9-10]. The technique used in this report is different from those of Winter and of Elliott, but it is mathematically related to Elliott's technique.

REVIEW OF TAYLOR SYNTHESIS PROCEDURE

A brief review of the Taylor synthesis procedure is given here. The key to this procedure is the equal-sidelobe pattern function which is the continuous-aperture analog to the Chebyshev polynomial pattern for arrays:

$$E(u) = \cos \pi \sqrt{u^2 - A^2}, \quad (1)$$

where $u = \pi a \sin \theta / \lambda$, a is the length of the aperture and θ is the angle measured relative to the normal to the array. This function has a maximum value of $\cosh \pi A$ at $u = 0$ and unit sidelobes extending to $u = \pm \infty$. Taylor showed that the pattern of Eq. (1) is not physically realizable from a continuous aperture distribution, just as the Dolph array excitation becomes increasingly impractical in the limit of large arrays. His brilliant solution to this problem was:

1. For all zeros of the synthesized pattern functions, which we will call $E_s(u)$, from the n th from the origin to ∞ , the locations will be the same as those from a uniformly illuminated aperture of the same size. That is,

$$E_s(u) = 0 \text{ for } u = n \text{ for } n \geq \bar{n}.$$

2. For the first $\bar{n} - 1$ zeros, their locations will be determined by the zeros of $E(u)$, scaled so that the n th zero is located at $u = \bar{n}$.

The aperture distribution is determined by performing a Woodward synthesis of $E_s(u)$. That is, we define a set of functions of the form

$$F_n(u) = \sin (u - n)\pi / (u - n)\pi,$$

and then construct $E_s(u)$ from the $F_n(u)$

$$E_s(u) = \sum_{n=-\infty}^{\infty} E_s(n) F_n(u). \quad (2)$$

Since we have defined $E_s(n) = 0$ for $n \geq \bar{n}$, Eq. (3) becomes

$$E_s(u) = \sum_{n=-\bar{n}+1}^{\bar{n}-1} E_s(n) F_n(u). \quad (3)$$

Fourier transformation of Eq. (3) yields the aperture distribution:

$$\begin{aligned}
 A(x) &= \int_{-\infty}^{\infty} E_s(u) e^{j2xu\pi/a} du \\
 &= \int_{-\infty}^{\infty} \sum_{n=-\bar{n}+1}^{\bar{n}-1} E_s(n) F_n(u) e^{j2xu\pi/a} du. \tag{4}
 \end{aligned}$$

That is, $A(x)$ is a weighted sum of integrals of the form,

$$\int_{-\infty}^{\infty} \frac{\sin(u-n)\pi}{(u-n)\pi} e^{j2xu\pi/a} du.$$

Letting $u' = u - n$ results in

$$e^{j2n\pi x/a} \int_{-\infty}^{\infty} \frac{\sin u'\pi}{u'\pi} e^{j2xu'\pi/a} du'.$$

Since the imaginary part of the integrand is odd, this becomes

$$\begin{aligned}
 &e^{j2n\pi x/a} \int_{-\infty}^{\infty} \frac{\sin u'\pi \cos 2xu'\pi/a}{u'\pi} du' \\
 &= e^{j2n\pi x/a} \int_{-\infty}^{\infty} \frac{1}{2} \left[\frac{\sin u'\pi(1-2x/a) + \sin u'\pi(1+2x/a)}{u'\pi} \right] du'. \tag{5}
 \end{aligned}$$

A standard definite integral is

$$\int_{-\infty}^{\infty} \frac{\sin bzdz}{z} = \begin{cases} \pi & \text{for } b > 0 \\ 0 & \text{for } b = 0 \\ -\pi & \text{for } b < 0 \end{cases}$$

Application of this integral to Eq. (5) and thence to Eq. (4) yields

$$\begin{aligned}
 A(x) &= \sum_{n=-\bar{n}+1}^{\bar{n}-1} E_s(n) e^{j2\pi nx/a} \\
 &= E_s(0) + 2 \sum_{n=1}^{\bar{n}-1} E_s(n) \cos 2\pi nx/a \quad \text{for } |x| \leq a/2 \\
 &= 0 \quad \text{for } |x| > a/2. \tag{6}
 \end{aligned}$$

The continuous aperture distribution given by Eq. (6) is sampled to give the element excitation values for a discrete array. This last step is approximate, and the pattern function of the array is obviously different from $E_s(u)$. This approximation is acceptable provided that the number of elements in the array is much greater than \bar{n} and the sidelobe level is not extremely low. Figure 1 is an example of a case in which the synthesis procedure gives an unsatisfactory result. For a sidelobe level of 50 dB below mainbeam and $\bar{n} = 8$, a 30-element array has the computed pattern function shown. The near-in sidelobes are unduly low, whereas the first eight sidelobes should be about the same level.

ARRAY PATTERN FUNCTIONS IN TERMS OF ZEROS

Elliott used a synthesis technique which relates the discrete array distribution directly with the array pattern [9]. We also use this relationship, and our procedure achieves identical results with those of Elliott. However, the actual computations are different, and it is desirable to compare the techniques.

Elliott expresses the pattern function as a polynomial in w , where $w = e^{j(2\pi s/\lambda)\sin \theta}$. The zeros of this polynomial are given by w_n , which are normally located on the unit circle. Once he has the w_n properly adjusted, he completes the synthesis by multiplying out the product expression, $\prod(w - w_n)$, into the polynomial. The coefficients of the polynomial are the excitations of the array elements.

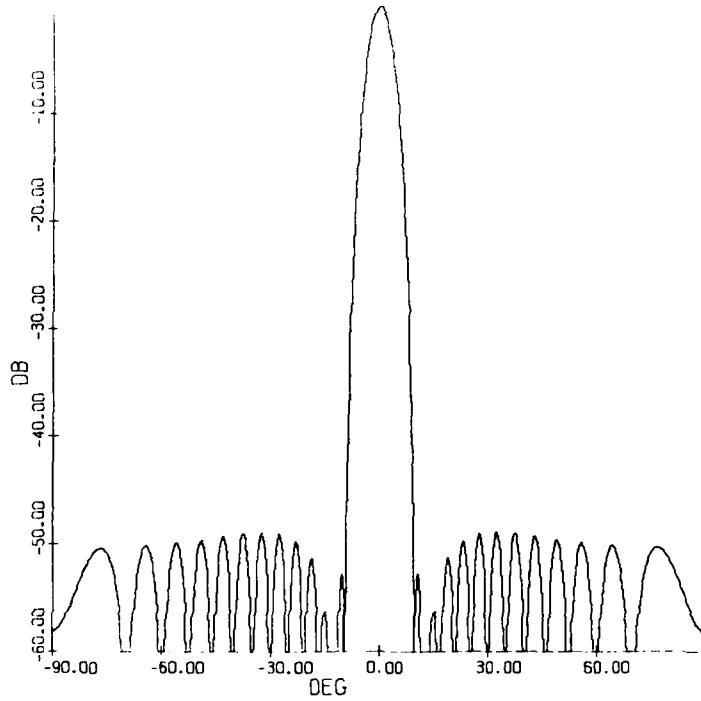


Fig. 1 — Conventional Taylor synthesis, $N = 30$, $\bar{n} = 8$, 50-dB sidelobes

Our procedure also uses the pattern function zeros in a product expression. Since the patterns are symmetric, our expression can be of the form, $\Pi(\cos z - \cos z_n)$, where $z = (2\pi s/\lambda) \sin \theta$. We cannot multiply this product expression out to obtain the coefficients directly since we require terms of the form $\cos nz$ rather than $\cos^n z$. Rather, we carry out a synthesis exactly analogous to that used by Taylor. Uniformly spaced pattern function samples are found by using the product expression. These pattern samples are used in a Fourier series to find the array illumination.

The procedure relies on the equivalent location of pattern function zeros for the line source and for the discrete array. Whereas the zeros for the pattern of a uniform line source distribution are located at $u = n$, the analogous relationship for a discrete array is $z = n\pi/N$, where $z = 2\pi s \sin \theta/\lambda$, where s is element spacing and N is the number of elements in the uniformly excited array.

The transformation of Taylor's procedure is easily seen to consist of locating the zeros in step 1 above at $z = n\pi/N$ for $n \geq \bar{n}$ and then scaling the first \bar{n} zeros of Eq. (1) so that the \bar{n} th zero is located at $z = \bar{n}\pi/N$.

Appendix A lists the resulting equations for Taylor arrays of both even and odd N , and Appendix B lists the equations for Bayliss arrays (yielding monopulse difference patterns) of both even and odd N . Figure 2 is an example of a Taylor array pattern with sidelobe levels of 50 dB with $\bar{n} = 8$ and $N = 30$. These equations can be straightforwardly programmed for automatic processing by a digital computer. Many programmable calculators now have sufficient memory to implement these programs. Appendix C lists programs for carrying out the synthesis and evaluating the pattern functions with an HP-41C programmable calculator.

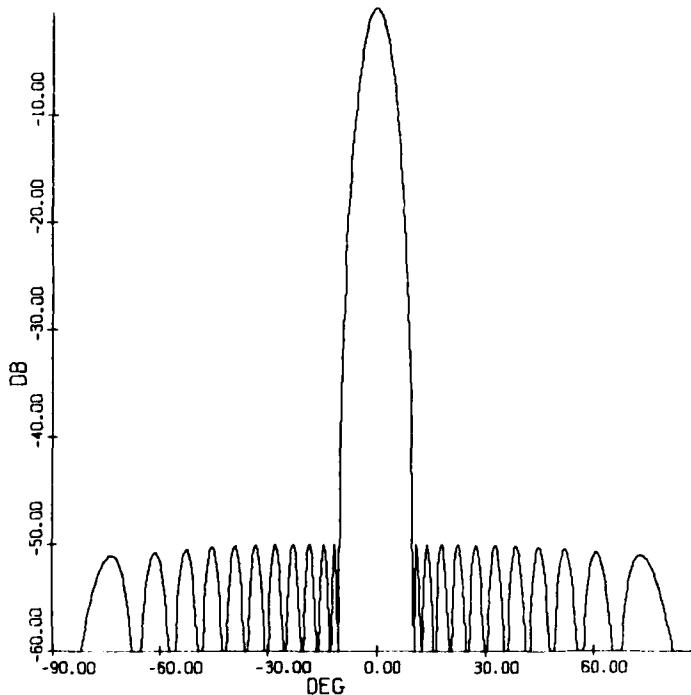


Fig. 2 — Discretized Taylor synthesis,
 $N = 30, \bar{n} = 8, 50$ -dB sidelobes

ACKNOWLEDGMENT

I thank Dr. Robert J. Adams for his careful and constructive review of the initial draft of this report. His questions led to a clarification of the relationship between this synthesis and that of Elliott [9].

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Appendix A

DESIGN EQUATIONS FOR LINEAR ARRAYS WITH TAYLOR-TYPE PATTERNS

These equations will determine the aperture illumination coefficients for a linear array of N elements to produce a Taylor-type pattern function with \bar{n} sidelobes on each side of the main beam at a level of L dB.

This design procedure involves three steps. The first $\bar{n} - 1$ zeros of the pattern are determined. Then the appropriate pattern function samples are determined. Finally, the array element illumination coefficients are determined by a harmonic analysis of the pattern function samples.

A particular advantage of this synthesis is that the knowledge of all of the pattern function zeros allows the computation of the pattern function as a product rather than as a polynomial. The product computation involves only one trigonometric function evaluation for each pattern function value. All other constants need to be evaluated only once for each array.

The pattern function zeros are given by

$$z_n = \frac{2\pi\bar{n}\sqrt{A^2 + (n - 1/2)^2}}{N\sqrt{A^2 + (\bar{n} - 1/2)^2}} \quad \text{for } n = 1 \text{ to } \bar{n} - 1 \quad (\text{A1a})$$

$$= \frac{2\pi n}{N} \quad \text{for } n = \bar{n} \text{ to } M, \quad (\text{A1b})$$

where

$$M = \text{int}\left(\frac{N - 1}{2}\right)$$

and A is given by

$$A = \frac{1}{\pi} \cosh^{-1} \left[10^{(L/20)} \right] \quad (\text{A2a})$$

$$\approx (L + 6.02)/27.29, \quad (\text{A2b})$$

where L is the sidelobe level (positive) in dB. Equation (A2b) is an excellent approximation, especially for large L .

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The pattern function is given by

$$\begin{aligned}
 E(z) &= \cos \frac{z}{2} \prod_{n=1}^M \left(\frac{\cos z - \cos z_n}{1 - \cos z_n} \right) & N \text{ even} \\
 &= \prod_{n=1}^M \left(\frac{\cos z - \cos z_n}{1 - \cos z_n} \right) & N \text{ odd}
 \end{aligned} \tag{A3}$$

The pattern samples to be used to find the array element illumination coefficients are given by

$$a_m = E \left(\frac{2\pi m}{N} \right) \quad \text{for } m = 1 \text{ to } \bar{n} - 1. \tag{A4}$$

The element excitation coefficients are given by

$$\begin{aligned}
 e_p &= 1 + 2 \sum_{m=1}^{\bar{n}-1} a_m \cos \frac{m(2p-1)\pi}{N} & N \text{ even}, p = 1 \text{ to } M+1 \\
 &= 1 + 2 \sum_{m=1}^{\bar{n}-1} a_m \cos \frac{2mp\pi}{N} & N \text{ odd}, p = 0 \text{ to } M,
 \end{aligned} \tag{A5}$$

where p is an index or element number starting at the center and moving to either end of the array.

Appendix B

DESIGN EQUATIONS FOR LINEAR ARRAYS WITH BAYLISS-TYPE DIFFERENCE PATTERNS

Appendix A gave the design equations for linear arrays with Taylor-type patterns, which produce a main beam with slightly larger beamwidth than that of the Dolph synthesis but in general with higher gain. In some applications, such as monopulse, we might require a difference pattern. Bayliss presented a synthesis procedure for difference patterns, analogous to that of Taylor. In this appendix we adapt the Bayliss procedure to discrete arrays.

As in the case of the Taylor synthesis, the application of discrete arrays involves three steps. The first $\bar{n} - 1$ off-axis zeros of the pattern are determined. Then the appropriate pattern function samples are determined. Finally the array element illumination coefficients are determined by a harmonic analysis of the pattern function samples.

The pattern function zeros are given by

$$z_n = \frac{2\pi q_n \left(\bar{n} + \frac{1}{2} \right)}{N \sqrt{A^2 + \bar{n}^2}} \quad \text{for } n = 1, 2, 3, 4 \quad (\text{B1a})$$

$$= \frac{2\pi \left(\bar{n} + \frac{1}{2} \right) \sqrt{A^2 + n^2}}{N \sqrt{A^2 + \bar{n}^2}} \quad \text{for } n = 5 \text{ to } \bar{n} - 1 \quad (\text{B1b})$$

$$= \frac{2\pi \left(n + \frac{1}{2} \right)}{N} \quad \text{for } n = \bar{n} \text{ to } M \quad (\text{B1c})$$

where

$$M = \text{int} \left(\frac{N - 2}{2} \right).$$

In this case it is necessary to find both A and q_n from graphs in Bayliss's paper [4]. For 50 dB sidelobes, $A = 2.42$, $q_1 = 2.78$, $q_2 = 3.18$, $q_3 = 3.85$, and $q_4 = 4.65$.

The pattern function is given by

$$E(z) = \sin \frac{z}{2} \prod_{n=1}^M \left[\cos z - \cos z_n \right] / \sin \frac{z_1}{4} \prod_{n=1}^M \left[\cos \frac{z_1}{2} - \cos z_n \right] \quad N \text{ even} \quad (\text{B2})$$

$$= \sin z \prod_{n=1}^M \left[\cos z - \cos z_n \right] / \sin \frac{z_1}{2} \prod_{n=1}^M \left[\cos \frac{z_1}{2} - \cos z_n \right] \quad N \text{ odd}$$

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$E(z)$ is normalized to unity at $z = z_1/3$, which is near the pattern maximum. If a more precise pattern maximum is desired, a better multiplying constant can easily be found.

The pattern samples to be used to find the array element illumination coefficients are given by

$$b_m = E \left(\frac{\pi}{N} (2m - 1) \right) \quad \text{for } m = 1 \text{ to } \bar{n} . \quad (B3)$$

The element excitation coefficients are given by

$$\begin{aligned} e_p &= 2 \sum_{m=1}^{\bar{n}} b_m \sin \frac{\pi(2m-1)(2p-1)}{2N} \quad \text{for } N \text{ even, } p = 1 \text{ to } M+1 \\ &= 2 \sum_{m=1}^{\bar{n}} b_m \sin \frac{\pi(2m-1)p}{N} \quad \text{for } N \text{ odd, } p = 1 \text{ to } M+1 \end{aligned} \quad (B4)$$

where p is an index of the element number starting with zero at the center of the array. For N odd, the center element of the array always has zero excitation. The excitations on one side of the array are the negative of those on the other side.

Appendix C

PROGRAMS FOR THE HP-41C CALCULATOR

This appendix presents programs for the HP-41C calculator for the design equations of Appendices A and B. The software consists of four programs, SUM, DIF, IN, and SL. "SUM" contains the equations for synthesizing Taylor-type sum patterns; "DIF" contains equations for Bayliss-type difference patterns; "IN" contains subroutines that are used by both programs; and "SL" is a routine for calculating the peaks of the sidelobes of the synthesized array. The number of registers used by the programs and the number of card sides required for storage are:

Program	Registers	Card Sides
SUM	30	2
DIF	42	3
IN	39	3
SL	19	2
	<hr style="border: 0; border-top: 1px solid black; margin-bottom: 5px;"/>	<hr style="border: 0; border-top: 1px solid black;"/>
	130	10 (5 cards) .

It is possible to synthesize aperture distributions using either SUM and IN or DIF and IN. These programs require at least one additional memory module. Furthermore, the programs use nine registers for variables, indices, and constants. Table C1 correlates the number of registers available for synthesis parameters with the number of additional memory modules in use. The available registers are used for the pattern samples a_m and b_m and for the pattern function zeros (cosines) z_p . The number of these registers is $\bar{n} + M$. Therefore, the size of array that can be synthesized for any given configuration of Table C1 depends on \bar{n} . For a 50-dB sidelobe requirement, \bar{n} will be about 8. Roughly speaking, an array of 55 to 65 elements for difference and 80 to 90 for sum can be synthesized using one memory module by trading programs in and out of the machine, and an array of 90 to 100 elements can be synthesized with all programs loaded using two modules. The maximum array size that can be handled using three modules is 310 to 320 for difference and about 340 for sum. It appears that one or two memory modules should suffice for most requirements.

Table C1 — Registers Available after Loading
Indicated Program Complements

Program Complement	Number of Memory Modules		
	1	2	3
SUM + IN	48	112	176
DIF + IN	35	99	163
SUM + DIF + IN	11	71	135
SUM + DIF + IN + SL	—	54	118

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The procedure for running the programs is:

1. Allocate memory by XEQ SIZE ($9 + M + n$).
2. Load the appropriate program complement.
3. Enter either XEQ SUM or XEQ DIF.
4. The display will prompt for N , L , and $NBAR$. N can be even or odd. L is sidelobe level in positive dB. DIF will also prompt for A , $Q1$, $Q2$, $Q3$, $Q4$.
5. After calculating z_n and loading $\cos z_n$ into registers starting with $(9 + \bar{n})$, the display will ask whether you want a listing of peak sidelobes (SL) or aperture distribution (EP). After the sidelobes or excitation coefficients are listed, the display will ask whether you want the other set of parameters calculated and listed.

The routine SL computes the sidelobe level relative to the main beam level by evaluating the pattern value at a point midway between pattern zeros. This computation is admittedly approximate because the pattern maximum is in general not exactly midway between zeros. The main beam pattern value is computed for $z = 0$. The difference pattern maximum is computed for $z = z_1/3$. This factor was found to be accurate for 50 dB sidelobes. The exact multiplying factor will be somewhat larger for higher sidelobes ($L < 50$), and it can be found quickly by obtaining z_1 and executing PA:

RCL ($9 + \bar{n}$)	gives $\cos z_1$
ACOS	gives z_1
k	new multiplying factor, such as .4
*	
COS	
STO 02	
XEQ PA .	

Alternatively, k can be found from Fig. 4 of Bayliss^{C1}, which defines the beam maximum by p_o , where $k = p_o / \S_1$. (\S_1 corresponds to our z_1)

Once the desired value of k has been found, go to lines 110, 111 in DIF, and exchange k , * for 3/. It is now necessary to reload the reference main beam pattern value into R08. This calculation starts at line 61 of SUM and 105 of DIF. Alternatively, you can simply rerun the program.

The pattern value, in voltage and normalized to mainbeam level, is found by keying in the value of z in degrees, then keying COS, STO 02, XEQ PA.

The registers used are:

00	N
01	M
02	A^2 and $\cos z_m$ for PA
03	n
04, 05	loop indices
06	multiplying constants

^{C1} E. T. Bayliss, BSTJ, May-Jun 1968, pp. 623-650.

07	accumulator for $E(z)$, e_p
08	main beam reference value
09 to $(8 + \bar{n})$	computed values of a_m , b_m
$(9 + \bar{n})$ to $(8 + \bar{n} + M)$	computed values of $\cos z_n$.

Program IN contains the following subroutines:

IN	Asks for input data N , L , $NBAR$
ZN	Completes calculation and storage of $\cos z_n$
BR	Asks for choice of sidelobes or aperture distribution and branches to EP or SL
PR	Prints element excitations e_p
PA	Computes pattern value for a_m , b_m , or SL routines
EP	Completes calculation of e_p .

The programs use flags 00 and 01 to indicate the following conditions:

Flag 00 is set for N even
clear for N odd

Flag 01 is set for DIF execution
clear for SUM execution.

The use of registers by program PA precludes the use of the plot subroutines resident in the printer.

Note that the sidelobes and pattern values obtained with these programs are all relative to the main beam level. No information concerning gain or aperture illumination efficiency is computed. The aperture distribution can be used to compute aperture efficiency or gain.

The programs and sample printouts are listed on the following pages.

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0.000000000	55 LBL 02	106 *	23 RCL
02 SF 01	56 RCL 04	109 *	24 *
03 INT 04	57 INT	110 STO 04	25 36RT
04 RCL 08	58 XEQ "ZN"		26 *
05 *	59 ISG 04	111 LBL 04	27 RCL 03
06 *	60 GT0 08	112 1	28 5
07 *	61 1	113 RCL 03	29 *
08 *	62 STO 02	114 1	30 *
09 INT	63 STO 08	115 *	31 STO 06
10 STO 01	64 XEQ "FA"	116 1 E-3	32 5
11 360	65 STO 08	117 *	33 RCL 03
12 RCL 03	66 XEQ "BR"	118 *	34 XCY
13 *		119 STO 05	35 GT0 07
14 RCL 06	67 LBL "S"	120 0	36 1.000
15 *	68 RCL 05	121 STO 07	37 STO 04
16 RCL 03	69 1		38 STO 06
17 .5	70 -	122 LBL 05	
18 -	71 1 E-3	123 XEQ "EP"	39 LBL 07
19 X12	72 *	124 ISG 05	40 1
20 RCL 07	73 1	125 GT0 05	41 *
21 *	74 *	126 2	42 1 E-3
22 SQRT	75 STO 05	127 RCL 07	43 *
23 *	76 360	128 *	44 *
24 STO 06	77 RCL 08	129 1	45 STO 04
25 RCL 03	78 *	130 *	
26 1	79 STO 06	131 XEQ "PR"	46 LBL 06
27 -		132 GT0 04	47 RCL 04
28 1 E-3	80 LBL 03	133 END	48 INT
29 *	81 RCL 06		49 ENT 0
30 1	82 RCL 05		50 FIX 0
31 *	83 INT		51 RCL X
32 STO 04	84 *	PRP "DIF"	52 PROMPT
	85 COS		53 XCY
33 LBL 01	86 STO 02	81 LBL "DIF"	54 "0"
34 RCL 04	87 XEQ "PA"	82 SF 01	55 RCL *
35 INT	88 RCL 05	83 XEQ "IN"	56 RCR
36 .5	89 8	84 RCL 06	57 *
37 -	90 *	85 2	58 RCR
38 X12	91 XCY	86 -	59 RDN
39 RCL 02	92 STO IND Y	87 2	60 FIX 2
40 *	93 ISG 05	88 *	61 ACX
41 SQRT	94 GT0 03	89 INT	62 PRBUF
42 XEQ "ZN"	95 90	90 STO 61	63 XEQ "ZN"
43 ISG 04	96 RCL 08	91 "R="	64 ISG 04
44 GT0 01	97 *	92 PROMPT	65 GT0 06
45 RCL 61	98 STO 06	93 FIX 2	66 5
46 1 E-3	99 1	94 RCL X	67 RCL 03
47 *	100 1	95 PRP	68 1
48 RCL 03	101 FC0 00	96 X12	69 *
49 *	102 0	97 STO 02	70 XCY
50 STO 04	103 FC0 00	98 360	71 GT0 16
51 360	104 0	99 RCL 06	72 1 E-3
52 RCL 08	105 RCL 01	100 *	73 *
53 *	106 *	101 RCL 02	74 *
54 STO 06	107 1 E-3	102 RCL 03	75 STO 04

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76+ LBL 80	126	81+ LBL 14	52 PROMPT
77 RCL 80	125 STO 04	82 RTN 0	53 X=0
78 RCL 84		83 SF 00	54 RTN
79 14	130+ LBL 14	84 N	55 STO 81
80 + 2	131 RCL 01	85 PROMPT	
81 -	132 INT	86 SF 00	56+ LBL 22
82 300	133 1	87 PFA	57 E1
83 XE0 21	134 *	88 STO 09	58 RCL 82
84 105 04	135 *	89 1	59 INT
85 STO 02	136 -	10 -	60 RTN 0
	137 RCL 06	11 ENTER	61 RCL 0
86+LBL 10	138 *	12 FRC	62 RCR
87 368	139 COS	13 X=0	63 INT 4
88 RCL 08	140 STO 02	14 SF 00	64 T=1
89 *	141 XE0 "PA"	15 LFT	65 RCR
90 STO 08	142 RCL 05	16 PROMPT	66 PBN
91 RCL 03	143 0	17 ARCL X	67 RTN
92 RCL 01	144 *	18 PPA	68 PREUP
93 1 E-3	145 X01	19 20	69 ISG 04
94 *	146 STO IND Y	20 *	70 RTN
95 *	147 ISG 05	21 1	71 RTN
96 STO 04	148 STO 14	22 LOG	72 "SLT" 0"
	149 RCL 21	23 *	73 PROMPT
97+LBL 11	150 1	24 *	74 X=0
98 RCL 04	151 *	25 E1X	75 STO "SL"
99 INT	152 1 E-3	26 LOG	76 STOP
100 15	153 *	27 PI	
101 *	154 1	28 *	77+LBL "PP"
102 XE0 "2N"	155 *	29 *	78 RCL 6
103 ISG 04	156 STO 04	30 RT2	79 1 E-5
104 STO 11	157 98	31 STO 02	80 *
105 RCL 03	158 RCL 00	32 "MEAR="	81 1
106 3	159 *	33 PROMPT	82 *
107 +	160 STO 06	34 ARCL X	83 STO 04
108 RCL IND 1		35 PPA	84 1
109 ACOS	161+LBL 15	36 STO 03	85 STO 07
110 3	162 1	37 RTN	
111	163 RCL 03		86+LBL 08
112 COS	164 1 E-3		87 RCL 04
113 STO 02	165 *	38+LBL "2N"	88 RCL 03
114 1	166 *	39 RCL 04	
115 STO 02	167 STO 05	40 *	89 *
116 XE0 "PA"	168 0	41 COS	90 3
117 STO 08	169 STO 07	42 RCL 02	91 *
118 XE0 "PA"		43 0	92 RCL 02
	170+LBL 16	44 *	93 RCL IND 1
119+LBL "2N"	171 XE0 "PP"	45 RCL 04	94 -
120 RCL 03	172 100 05	46 *	95 ST* RT
121 1 E-3	173 STO 16	47 X01 1	96 ISG 04
122 *	174 2	48 STO IND	97 STO 08
123 1	175 RCL 07	49 RTN	98 1
124 +	176 *		99 PBT 06
125 STO 05	177 XE0 "PP"	50+LBL "2N"	100 STO 01
126 108	178 STO 15	51+SLT 1MERT 0	101 FCT 01
127 RCL 09	179 STOP		102 STO 07
	180 END		103 RCL 02

SHELTON

104 A003	151•LBL 05
105 SIN	152 RCL 05
106 GTO 03	153 3
	154 *
107•LBL 01	155 X(X)
108 RCL 02	156 RCL IND
109 A005	157 *
110 2	158 ST+ 07
111 *	159 RTN
112 F52 01	160 END
113 GTO 02	
114 COS	
115 GTO 03	
	PRP "SL"
116•LBL 02	
117 SIN	91•LBL "SL"
	02 "SL PEAKS/ DE"
118•LBL 03	03 PRG
119 RCL 07	04 FIX 2
120 *	05 1
121 RCL 06	06 RCL 03
122 *	07 1
123 RTN	08 -
	09 1 E-3
124•LBL "EP"	10 *
125 -1	11 *
126 FC? 00	12 GTO 05
127 0	
128 RCL 04	13•LBL 00
129 INT	14 RCL 03
130 2	15 6
131 *	16 *
132 +	17 RCL 05
133 RCL 05	18 *
134 INT	19 RCL IND X
135 2	20 ACOS
136 *	21 X(X)
137 FC? 01	22 1
138 GTO 03	23 +
139 1	24 X(X)
140 -	25 RCL IND Y
	26 ACOS
141•LBL 03	27 *
142 *	28 2
143 RCL 06	29 *
144 *	30 COS
145 F57 01	31 XEW 03
146 GTO 04	32 ISG 05
147 COS	33 GTO 00
148 GTO 05	34 RCL 03
	35 RCL 01
149•LBL 04	36 1 E-3
150 SIN	37 *
	38 +
	39 STG 05

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N=20		N=21	
L=50		L=50	
NBAR=3		NBAR=3	
E1= 1.9453		E0= 1.9573	
E2= 1.8435		E1= 1.9111	
E3= 1.6549		E2= 1.7766	
E4= 1.4621		E3= 1.5763	
E5= 1.1166		E4= 1.3156	
E6= 0.8294		E5= 1.0463	
E7= 0.5684		E6= 0.7766	
E8= 0.3527		E7= 0.5291	
E9= 0.1983		E8= 0.3306	
E10= 0.0965		E9= 0.1812	
		E10= 0.0957	

SL PEAKS, DE

36.33	***	36.35	***
49.93	***	49.95	***
49.82	***	49.86	***
49.72	***	49.77	***
49.60	***	49.67	***
49.45	***	49.56	***
49.29	***	49.43	***
49.09	***	49.26	***
49.09	***	49.29	***
		49.31	***

N=20

L=50		N=21	
NBAR=2		L=50	
A=3.42		NBAR=3	
Q1= 2.78		H=2.42	
Q2= 3.18		Q1= 2.78	
Q3= 3.85		Q2= 3.18	
Q4= 4.65		Q3= 3.85	
E1= 0.4886		Q4= 4.65	
E2= 1.3673		E1= 0.9093	
E3= 1.9531		E2= 1.6543	
E4= 2.2448		E3= 2.1161	
E5= 2.1554		E4= 2.2516	
E6= 1.6061		E5= 2.0875	
E7= 1.3679		E6= 1.7613	
E8= 0.8100		E7= 1.2231	
E9= 0.4164		E8= 0.7650	
E10= 0.1751		E9= 0.3353	
		E10= 0.1726	

SL PEAKS, DE

49.54	***	49.56	***
48.41	***	48.44	***
47.31	***	47.34	***
46.39	**	46.35	***
47.04	***	47.15	***
46.30	**	46.08	**
46.55	**	46.64	***
46.56	**	46.55	***
45.64	***	45.51	**

SL PEAKS, DE

